

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/063,979	DEWANJEE, PIJUSH K.	
	Examiner	Art Unit	Page 1 of 1
David Buttner	1712		

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2003/0171166	09-2003	Cavallaro et al.	473/371
B	US-6,486,261	11-2002	Wu et al.	525/332.6
C	US-2002/0098917	07-2002	Iwami, Satoshi	473/374
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Thain, Science and Golf IV, 7/2002; page 319-327
V	Chemical Abstract Registry # 13680-35-8
W	Chemical Abstract Registry # 5285-60-9
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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